

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/618,164	KWON ET AL.	
Examiner	Art Unit	
James Mackey	1722	

SEARCHED						
Class	Subclass	Date	Examiner			
425	89, 224, 308,315, 363,371, 447	7/25/2005	JPM			
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INTERFERENCE SEARCHED					
Examiner	Date	Subclass	Class		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Conducted INVENTOR name search in IFW	7/22/2005	JPM			
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